

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Kazutoshi OHMORI et al.

Appln. No.:

Filed: HERewith

For: SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

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INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

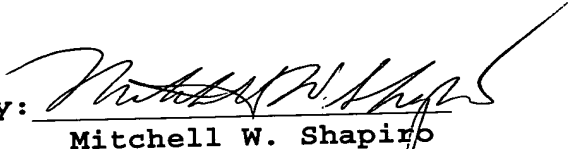
Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AH-AP and BH-BJ on the attached List were cited in the specification, on pages 2-4, and their relevance is indicated therein. Documents AA-AG are U.S. counterparts to Documents AH, AI, AL, AO, AP, BH, and BL, respectively.

Respectfully submitted,

MWS:sjk

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October 15, 2003

By: 
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FORM PTO-1449				Atty. Docket No. XA-9959		Appln. No.	
LIST OF DOCUMENTS CITED BY APPLICANT				Applicant Kazutohi OHMORI et al.			
				Filing Date HEREWITH		Group	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	6,479,408	11/12/02	Shioya et al.	438	789	
	AB	6,340,435	01/22/02	Bjorkman et al.	216	72	
	AC	2002/0168849	11/14/02	Lee et al.	438	637	
	AD	6,255,217	07/03/01	Agnello et al.	438	687	
	AE	2001/0054765	12/27/01	Ohto et al.	257	751	
	AF	2002/0192945	12/19/02	Nagahara	438	637	
	AG	2003/0030146	02/13/03	Tamaru et al.	257	762	
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AH	2001-326279	11/22/01	Japan			Abstract
	AI	2001-110789	04/20/01	Japan			Yes
	AJ	2002-203899	07/19/02	Japan			Abstract
	AK	2002-134494	05/10/02	Japan			Abstract
	AL	2002-353310	12/06/02	Japan			Abstract
	AM	2003-142593	05/16/03	Japan			Abstract
	AN	2003-152076	05/23/03	Japan			Abstract
	AO	2000-200832	07/18/00	Japan			Abstract
	AP	2002-9150	01/11/02	Japan			Abstract
OTHER (including author, title, date, pertinent pages, etc.)							
	AQ						
	AR						
	AS						
Examiner				Date Considered			
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				Filing Date HEREWITH		Group	
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	BA						
	BB						
	BC						
	BD						
	BE						
	BF						
	BG						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	BH	2002-373936	12/26/02	Japan			Abstract
	BI	2002-170882	06/14/02	Japan			Abstract
	BJ	2002-270691	09/20/02	Japan			Abstract
	BK	2002-324837	11/08/02	Japan			Abstract
	BL	2003-60030	02/28/03	Japan			Abstract
	BM						
	BN						
	BO						
	BP						
OTHER (including author, title, date, pertinent pages, etc.)							
	BQ						
	BR						
	BS						
Examiner				Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							